


Search Notes 	Application/Control No. 10759719	Applicant(s)/Patent Under Reexamination LEE ET AL.
	Examiner SHIN-HON CHEN	Art Unit 2131

SEARCHED			
Class	Subclass	Date	Examiner
380	256	3/28/08	S.C.

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - see search history)	3/28/08	S.C.
NPL search (IEEE explor and Google)	3/27/08	S.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner